

<b>Notice of References Cited</b>	Application/Control No. 10/776,122		Applicant(s)/Patent Under Reexamination BYUN ET AL.	
	Examiner Asok K. Sarkar		Art Unit 2829	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0106067	06-2004	Lin et al.	430/311
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0825492A1	02-1998	EPO	Yeo et al.	G03F 7/40
	O					
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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